

Search Notes**Application/Control No.**

10/020,628

Examiner

Mohamed Charioui

Applicant(s)/Patent under Reexamination

VISSER ET AL.

Art Unit

2857

SEARCHED

Class	Subclass	Date	Examiner
702	58, 59, 64, 117, 118, 119	11/16/2004	MC
702	123, 124	11/16/2004	MC
702	126, 185	11/16/2004	MC
702	189	11/16/2004	MC
324	72.5	11/16/2004	MC
324	527, 763	11/16/2004	MC
324	538, 763	11/16/2004	MC
324	765	11/16/2004	MC
714	734	11/16/2004	MC
715	4	11/16/2004	MC
Search	updated	8/10/2005	MC
Search	updated	5/2/2006	MC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Hal Wachsman	11/17/2004	MC
East: (error near message) with (pin or pins)	11/17/2004	MC
East: (((pin or pins) near5 voltage) with disconnect\$)	11/17/2004	MC
East: ((apply or applying or applied) near voltage near (pin or pins)) with "integrated circuits"	11/17/2004	MC
East: ((pin or pins) near10 connect\$ near10 (open or disconnect\$)) with voltage	11/17/2004	MC
East: (open near5 detect\$) with (pin or pins)	11/17/2004	MC
East: connection with (pin or pins) with voltage with resistor	11/17/2004	MC
Search updated	8/10/2005	MC

Search Notes (continued)



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